

# High Speed 3.3V CMOS 8-Bit Transceiver with Output Resistor

QS74LCX2245

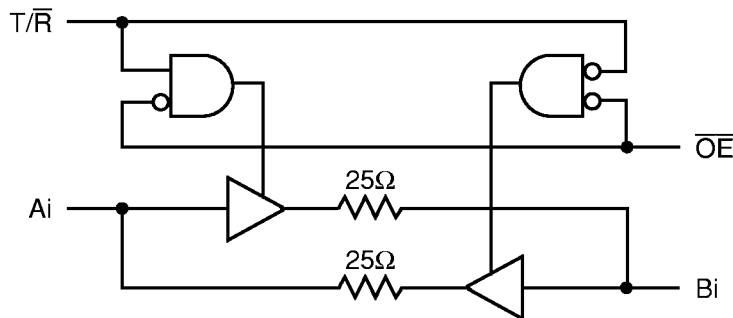
## FEATURES/BENEFITS

- 5V tolerant inputs and outputs
- 25Ω series resistor for low switching noise
- 10μA I<sub>CCQ</sub> quiescent power supply current
- Hot insertable
- 2.0V–3.6V V<sub>CC</sub> supply operation
- ±12mA balanced output drive
- Power down high impedance inputs and outputs
- Meets or exceeds JEDEC 36 specifications
- t<sub>PD</sub> = 7.0ns
- Input hysteresis for noise immunity
- Operating temperature range:  
 –40°C to 85°C
- Latch-up performance exceeds 500mA
- ESD performance:  
 Human body model > 2000V  
 Machine model > 200V
- Packages available:  
 20-pin QSOP  
 20-pin SOIC

## DESCRIPTION

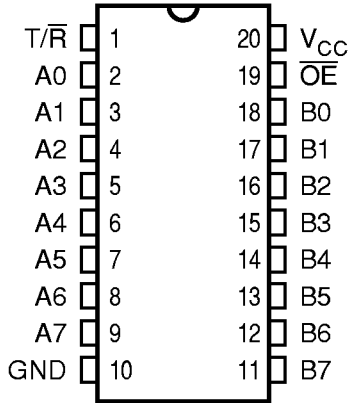
The LCX2245 is an 8-bit non-inverting transceiver with three-state outputs that is ideal for bus-oriented applications. The Transmit/Receive (T/R) input determines the direction of data flow, either from A to B or B to A, and the Output Enable ( $\overline{OE}$ ) inputs enables the selected port for output. The 3.3V LCXPlus family features low power, low switching noise, and fast switching speeds for low power portable applications as well as high-end, advanced workstation applications. 5V tolerant inputs and outputs allow this LCXPlus product to be used in mixed-voltage applications. The LCX2245 with integrated output resistor is ideally suited for low noise environments where reduced output overshoot and undershoot are critical requirements. To accommodate hot-plug or live insertion applications, this product is designed not to load an active bus when V<sub>CC</sub> is removed.

Figure 1. Functional Block Diagram



**Figure 2. Pin Configuration**  
(All Pins Top View)

SOIC, QSOP



**Table 1. Pin Description**

| Name             | I/O | Description               |
|------------------|-----|---------------------------|
| Ai               | I/O | Data Bus A                |
| Bi               | I/O | Data Bus B                |
| $\overline{T/R}$ | I   | Direction                 |
| $\overline{OE}$  | I   | Three-State Output Enable |

**Table 2. Function Table**

| $\overline{OE}$ | $\overline{T/R}$ | A      | B      | Function       |
|-----------------|------------------|--------|--------|----------------|
| H               | X                | Hi-Z   | Hi-Z   | Disable        |
| L               | L                | Output | Input  | Bus B to Bus A |
| L               | H                | Input  | Output | Bus A to Bus B |

**Table 3. Capacitance**

| Symbol    | Pins                          | Typ | Unit | Conditions  |
|-----------|-------------------------------|-----|------|---|
| $C_{IN}$  | Input Capacitance             | 7.0 | pF   | $V_{IN} = 0V, V_{OUT} = 0V, f = 1MHz$                           |
| $C_{I/O}$ | I/O Capacitance               | 8.0 | pF   | $V_{IN} = 0V, V_{OUT} = 0V, f = 1MHz$                           |
| $C_{PD}$  | Power Dissipation Capacitance | 20  | pF   | $V_{CC} = 3.3V, V_{IN} = 0V, \text{ or } V_{CC}$<br>$f = 10MHz$ |

**Note:** Capacitance is characterized but not production tested.

**Table 4. Absolute Maximum Ratings**

|   |                          |
|---|--------------------------|
| Supply Voltage to Ground .....                          | -0.5V to 7.0V            |
| DC Output Voltage $V_{OUT}$                             |                          |
| Outputs HIGH-Z .....                                    | -0.5V to 7.0V            |
| Outputs Active .....                                    | -0.5V to $V_{CC} + 0.5V$ |
| DC Input Voltage $V_{IN}$ .....                         | -0.5V to 7.0V            |
| DC Input Diode Current with $V_{IN} < 0$ .....          | -50mA                    |
| DC Output Diode Current                                 |                          |
| $V_O < 0$ .....   | -50mA                    |
| $V_O > V_{CC}$ .....                                    | 50mA                     |
| DC Output Source/Sink Current ( $I_{OH}/I_{OL}$ ) ..... | $\pm 50mA$               |
| DC Supply Current per Supply Pin .....                  | $\pm 100mA$              |
| DC Ground Current per Ground Pin .....                  | $\pm 100mA$              |
| $T_{STG}$ Storage Temperature .....                     | -65°C to 150°C           |

**Note:** Stresses greater than those listed under ABSOLUTE MAXIMUM RATINGS may cause permanent damage to QSI devices that result in functional or reliability type failures.

**Table 5. Recommended Operating Conditions**

| Symbol              | Parameter                           | Min                   | Max      | Unit |
|---------------------|-------------------------------------|-----------------------|----------|------|
| $V_{CC}$            | Supply Voltage, Operating           | 2.0                   | 3.6      | V    |
|                     | Supply Voltage, Data Retention Only | 1.5                   | 3.6      |      |
| $V_{IN}$            | Input Voltage                       | 0                     | 5.5      | V    |
| $V_{OUT}$           | Output Voltage in Active State      | 0                     | $V_{CC}$ | V    |
| $V_{OUT}$           | Output Voltage in "OFF" State       | 0                     | 5.5      | V    |
| $I_{OH}/I_{OL}$     | Output Current                      | $V_{CC} = 3.0 - 3.6V$ | $\pm 12$ | mA   |
|                     |                                     | $V_{CC} = 2.7V$       | $\pm 6$  |      |
| $\Delta t/\Delta v$ | Input Transition Slew Rate          | —                     | 10       | ns/V |
| $T_A$               | Operating Free Air Temperature      | -40                   | 85       | °C   |

**Table 6. DC Electrical Characteristics Over Operating Range**

Industrial Temperature Range,  $T_A = -40^{\circ}\text{C}$  to  $85^{\circ}\text{C}$ .

| Symbol       | Parameter                              | Test Conditions <sup>(1)</sup>   | Min                          | Typ <sup>(2)</sup> | Max                | Unit          |
|--------------|--|--|------------------------------|--------------------|--------------------|---------------|
| $V_{IH}$     | Input HIGH Voltage                     | Logic HIGH for All Inputs  | 2.0                          | —                  | —                  | V             |
| $V_{IL}$     | Input LOW Voltage                      | Logic LOW for All Inputs   | —                            | —                  | 0.8                | V             |
| $V_{OH}$     | Output HIGH Voltage                    | $V_{CC} = 2.7\text{V}, I_{OH} = -100\mu\text{A}$<br>$V_{CC} = 3.0\text{V}, I_{OH} = -12\text{mA}$<br>$V_{CC} = 3.0\text{V}, I_{OH} = -18\text{mA}$ | $V_{CC} - 0.2$<br>2.4<br>2.2 | —<br>—<br>—        | —<br>—<br>—        | V             |
| $V_{OL}$     | Output LOW Voltage                     | $V_{CC} = 2.7\text{V}, I_{OL} = 100\mu\text{A}$<br>$V_{CC} = 3.0\text{V}, I_{OL} = 12\text{mA}$<br>$V_{CC} = 3.0\text{V}, I_{OL} = 18\text{mA}$    | —<br>—<br>—                  | —<br>—<br>—        | 0.2<br>0.55<br>0.8 | V             |
| $\Delta V_T$ | Input Hysteresis <sup>(3)</sup>        | $V_{TLH} - V_{THL}$ for All Inputs   | —                            | 150                | —                  | mV            |
| $ I_{OZ} $   | Off-State Output Current (Hi-Z)        | $V_{CC} = 3.6\text{V}, V_O = 0\text{V},$<br>$V_O = 5.5\text{V}$  | —                            | —                  | 1                  | $\mu\text{A}$ |
| $I_{OS}$     | Short Circuit Current <sup>(3,4)</sup> | $V_{CC} = 3.6\text{V}, V_{OUT} = \text{GND}$   | -60                          | —                  | -200               | mA            |
| $I_{OR}$     | Current Drive <sup>(3)</sup>           | $V_{CC} = 2.7\text{V}, V_{OUT} = 2.0\text{V}$  | 40                           | —                  | —                  | mA            |
| $V_{IK}$     | Input Clamp Voltage                    | $V_{CC} = 2.7\text{V}, I_{IN} = -18\text{mA}$  | —                            | -0.7               | -1.2               | V             |
| $I_I$        | Input Leakage Current                  | $V_I = 0\text{V}, V_I = 5.5\text{V},$<br>$V_{CC} = 3.6\text{V}$  | —                            | —                  | $\pm 1.0$          | $\mu\text{A}$ |
| $R_{OUT}$    | Output Resistance                      | $V_{CC} = 3.0\text{V}, I_{OL} = 12\text{mA}$   | —                            | 28                 | —                  | $\Omega$      |
| $I_{OFF}$    | Power Off Leakage                      | $V_{CC} = 0\text{V}, V_I \text{ or } V_O = 5.5\text{V}$  | —                            | —                  | 10                 | $\mu\text{A}$ |

**Notes:**

1. For conditions shown as Min. or Max. use appropriate value specified under Recommended Operating Conditions for the applicable device type.
2. Typical values are at  $V_{CC} = 3.3\text{V}$  and  $T_A = 25^{\circ}\text{C}$ .
3. These parameters are guaranteed by characterization, but not production tested.
4. Not more than one output should be tested at one time. Duration of test should not exceed one second.

**Table 7. Power Supply Characteristics**

| Symbol          | Parameter  | Test Conditions <sup>(1)</sup>  | Typ <sup>(2)</sup>                         | Max                | Unit               |      |
|-----------------|--|---|--|--------------------|--------------------|------|
| $I_{CC}$        | Quiescent Power Supply Current                     | $V_{CC} = 3.6V$ , Freq = 0<br>$V_{IN} = GND$ or $V_{CC}$  | 0.1  | 10                 | $\mu A$            |      |
| $\Delta I_{CC}$ | Supply Current per Input @ TTL HIGH <sup>(3)</sup> | $V_{CC} = 3.6V$<br>$V_{IN} = V_{CC} - 0.6V$ , Freq = 0  | 2.0  | 30                 | $\mu A$            |      |
| $I_{CCD}$       | Supply Current per Input per MHz <sup>(4)</sup>    | $V_{CC} = 3.6V$ , Outputs Open<br>One Bit Toggling @ 50% Duty Cycle<br>$\overline{OE} = GND$                      | 50   | 75                 | $\mu A / MHz$      |      |
| $I_C$           | Total Power Supply Current <sup>(6)</sup>          | $V_{CC} = 3.6V$ , Outputs Open<br>One Bit Toggling<br>@ 50% Duty Cycle<br>$\overline{OE} = GND$ , $f = 10MHz$     | $V_{IN} = V_{CC} - 0.6V$<br>$V_{IN} = GND$ | 0.5 <sup>(5)</sup> | 0.8 <sup>(5)</sup> | $mA$ |
|                 |  | $V_{CC} = 3.6V$ , Outputs Open<br>Eight Bits Toggling<br>@ 50% Duty Cycle<br>$\overline{OE} = GND$ , $f = 2.5MHz$ | $V_{IN} = V_{CC} - 0.6V$<br>$V_{IN} = GND$ | 1.0 <sup>(5)</sup> | 1.7 <sup>(5)</sup> | $mA$ |

**Notes:**

- For conditions shown as Min. or Max., use the appropriate values specified under Recommended Operating Conditions for applicable device type.
- Typical values are at  $V_{CC} = 3.3V$ , 25°C ambient.
- Per TTL driven input. All other inputs at  $V_{CC}$  or GND.
- This parameter is not directly testable, but is derived for use in total power supply calculations.
- Values for these conditions are examples of the  $I_{CC}$  formula. These limits are guaranteed by design but not tested.
- $I_C = I_{QUIESCENT} + I_{INPUTS} + I_{DYNAMIC}$   
 $I_C = I_{CCQ} + \Delta I_{CC} D_H N_T + I_{CCD} f N_O$   
 $I_{CCQ} =$  Quiescent Current ( $I_{CCL}$ ,  $I_{CCH}$ , and  $I_{CCZ}$ ).  
 $\Delta I_{CC} =$  Power Supply Current for a TTL-High Input ( $V_{IN} = V_{CC} - 0.6V$ ).  
 $D_H =$  Duty Cycle for TTL High Inputs.  
 $N_T =$  Number of TTL High Inputs.  
 $I_{CCD} =$  Dynamic Current Caused by an Input Transition Pair (HLH or LHL).  
 $f =$  Average Switching Frequency per Output.  
 $N_O =$  Number of Outputs Switching.

**Table 8. Dynamic Switching Characteristics<sup>(1)</sup>**

| Symbol    | Parameter                            | Conditions                                     | $V_{CC}$<br>(V) | $T_A = 25^\circ C$ | Units |
|-----------|--------------------------------------|--|-----------------|--------------------|-------|
|           |                                      |  |                 | Typical            |       |
| $V_{OLP}$ | Quiet Output Dynamic Peak $V_{OL}$   | $C_L = 30pF$ , $V_{IH} = 3.3V$ , $V_{IL} = 0V$ | 3.3             | 0.8                | V     |
| $V_{OLV}$ | Quiet Output Dynamic Valley $V_{OL}$ | $C_L = 30pF$ , $V_{IH} = 3.3V$ , $V_{IL} = 0V$ | 3.3             | 0.8                | V     |

**Note:**

- Characterized but not production tested.

**Table 9. Switching Characteristics Over Operating Range**

Industrial Temperature Range,  $T_A = -40^{\circ}\text{C}$  to  $85^{\circ}\text{C}$ .

$C_{\text{LOAD}} = 30\text{pF}$ ,  $R_{\text{LOAD}} = 500\Omega$  unless otherwise noted.

| Symbol                               | Description <sup>(1)</sup>  | $V_{\text{CC}} = 3.3 \pm 0.3\text{V}$ |     | $V_{\text{CC}} = 2.7\text{V}^{(2)}$ |     | Unit |
|--------------------------------------|---|---------------------------------------|-----|-------------------------------------|-----|------|
|                                      |   | Min                                   | Max | Min                                 | Max |      |
| $t_{\text{PHL}}$<br>$t_{\text{PLH}}$ | Propagation Delay<br>Ai to Bi   | 1.5                                   | 7.0 | 1.5                                 | 8.0 | ns   |
| $t_{\text{PZH}}$<br>$t_{\text{PZL}}$ | Output Enable Time<br>$\overline{\text{OE}}$ to A/B                   | 1.5                                   | 8.5 | 1.5                                 | 9.5 | ns   |
| $t_{\text{PHZ}}$<br>$t_{\text{PLZ}}$ | Output Disable Time <sup>(2)</sup><br>$\overline{\text{OE}}$ to A/B   | 1.5                                   | 7.5 | 1.5                                 | 8.5 | ns   |
| $t_{\text{PZH}}$<br>$t_{\text{PZL}}$ | Output Enable Time <sup>(2)</sup><br>T/ $\overline{\text{R}}$ to A/B  | 1.5                                   | 8.5 | 1.5                                 | 9.5 | ns   |
| $t_{\text{PHZ}}$<br>$t_{\text{PLZ}}$ | Output Disable Time <sup>(2)</sup><br>T/ $\overline{\text{R}}$ to A/B | 1.5                                   | 7.5 | 1.5                                 | 8.5 | ns   |
| $t_{\text{SK(O)}}$                   | Output Skew <sup>(3)</sup>  | —                                     | 0.5 | —                                   | —   | ns   |

**Notes:**

1. Minimums guaranteed but not production tested. See test circuit and waveforms.
2. Guaranteed by characterization.
3. Skew between any two outputs of the same package switching in the same direction. This parameter is guaranteed by characterization but not production tested.

TEST CIRCUIT AND WAVEFORMS

Figure 3. Test Circuit

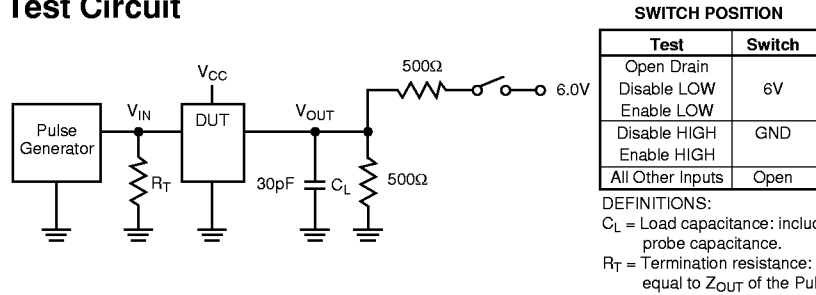


Figure 4. Setup, Hold, and Release Timing

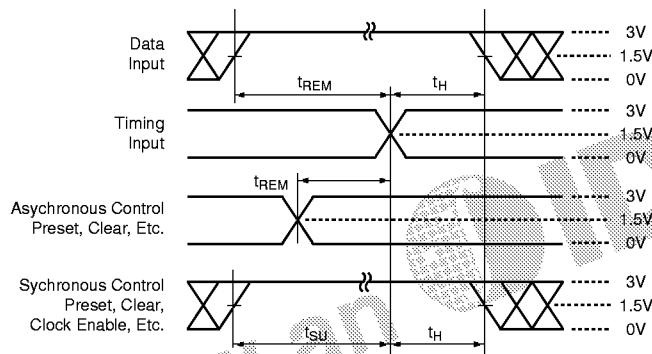


Figure 6. Pulse Width

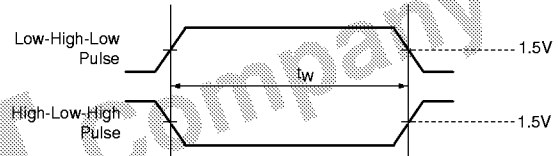


Figure 5. Enable and Disable Timing

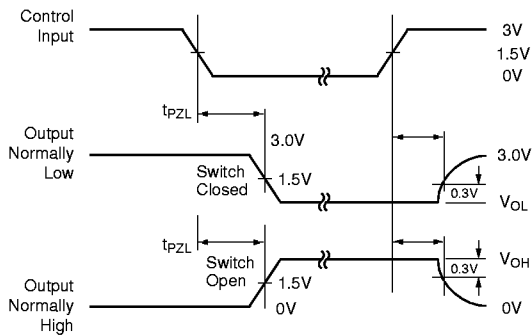
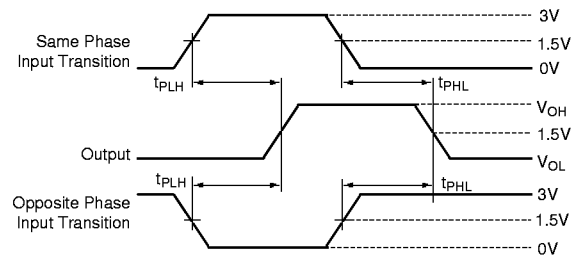


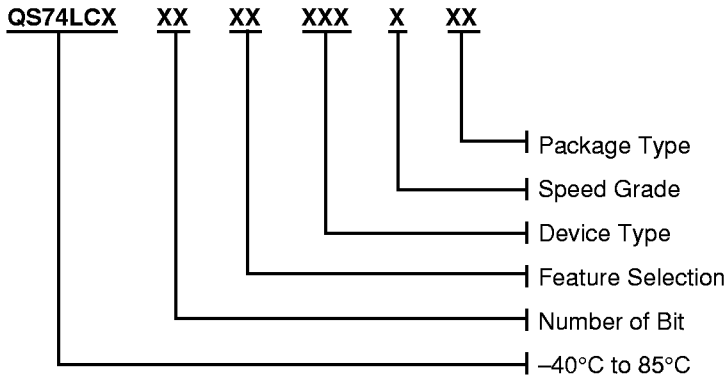
Figure 7. Propagation Delay



Notes:

1. Input Control Enable = LOW and Input Control Disable = HIGH.
2. Pulse Generator for All Pulses: Rate  $\leq 1.0\text{MHz}$ ;  
 $Z_{OUT} \leq 50\Omega$ ;  $t_F, t_R \leq 2.5\text{ns}$ .

ORDERING INFORMATION



**Device Type:**

245

**Speed Grades:**

Blank – Standard

**Package Type:**

20-pin QSOP

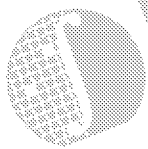
20-pin SOIC

**Feature Selection:**

2 – Output Resistor

**Number of Bit:**

Blank – 8-Bit

Now an  IDT company